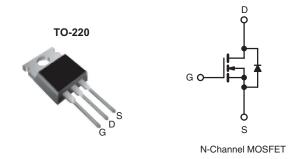


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	100	1000			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	5.0			
Q _g (Max.) (nC)	80				
Q _{gs} (nC)	10				
Q _{gd} (nC)	42				
Configuration	Single				



FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220		
Lead (Pb)-free	IRFBG30PbF		
Lead (Fb)-liee	SiHFBG30-E3		
SnPb	IRFBG30		
	SiHFBG30		

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	1000	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	\/ at 10 \/	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		3.1		
	V _{GS} at 10 V	T _C = 100 °C	I _D	2.0	Α	
Pulsed Drain Current ^a			I _{DM}	12	1	
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	280	mJ	
Repetitive Avalanche Current ^a			I _{AR}	3.1	A	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation	T _C =	25 °C	P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	1.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6 20 or N	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF MIS SCIEW			1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 55 \,^{\circ}\text{mH}$, $R_G = 25 \,^{\circ}\Omega$, $I_{AS} = 3.1 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le 3.1$ A, $dI/dt \le 80$ A/ μ s, $V_{DD} \le 600$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFBG30, SiHFBG30

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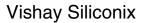


THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

SPECIFICATIONS $T_J = 25 ^{\circ}C$,	ariicoo otriciv	vise rioleu				,	
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		1000	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		1.4	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I_{GSS}	Vo	V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 10	V _{DS} = 1000 V, V _{GS} = 0 V		-	100	μΑ
		$V_{DS} = 800 \text{ V}, \text{ V}$	V _{DS} = 800 V, V _{GS} = 0 V, T _J = 125 °C		-	500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 1.9 A^b$	-	-	5.0	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 10 V, I _D = 1.9 A ^b		2.1	-	-	S
Dynamic							
Input Capacitance	C_{iss}	V _{GS} = 0 V,		-	980	-	pF
Output Capacitance	C _{oss}	V	V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		140	-	
Reverse Transfer Capacitance	C_{rss}	f = 1.0			50	-	
Total Gate Charge	Q_g		$V_{GS} = 10 \text{ V}$ $I_D = 3.1 \text{ A, } V_{DS} = 400 \text{ V, } - 400 \text{ See fig. 6 and } 13^{\text{b}}$	-	-	80	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V		-	-	10	
Gate-Drain Charge	Q_{gd}			-	-	42	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 500 V, I_{D} = 3.1 A R_{G} = 12 Ω , R_{D} = 170 Ω , see fig. 10 ^b		-	12	-	- ns
Rise Time	t _r			-	25	-	
Turn-Off Delay Time	t _{d(off)}			-	89	-	
Fall Time	t _f			-	29	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	n I I
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		=	-	3.1	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	12	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 3.1 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 3.1 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	410	620	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.3	2.0	μС
Forward Turn-On Time	t _{on}	Intrinsic turn	n-on is dominated by L _S and L _D)				

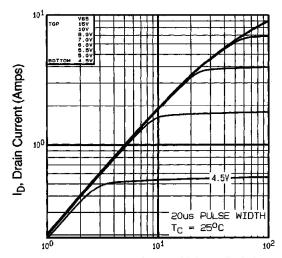
Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 V_{DS} , Drain-to-Source Voltage (volts) Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

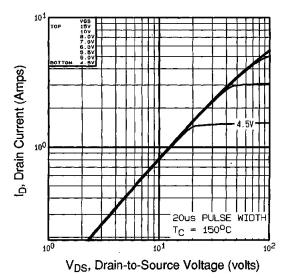


Fig. 3 - Fig. 2 - Typical Output Characteristics, T_C = 150 °C

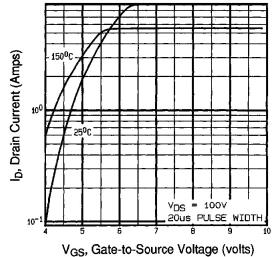


Fig. 3 - Typical Transfer Characteristics

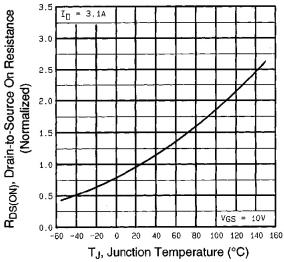
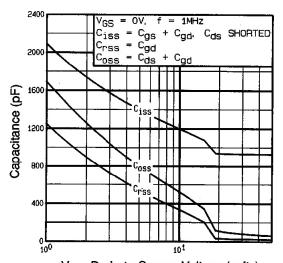


Fig. 4 - Normalized On-Resistance vs. Temperature

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V_{DS}, Drain-to-Source Voltage (volts)
Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

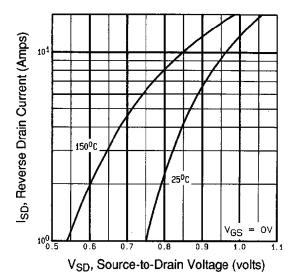


Fig. 7 - Typical Source-Drain Diode Forward Voltage

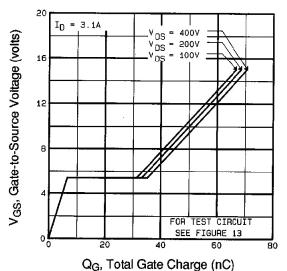


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

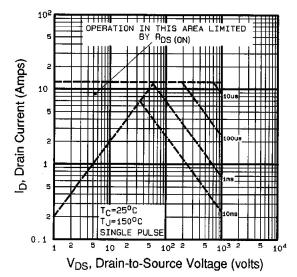
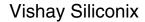


Fig. 8 - Maximum Safe Operating Area





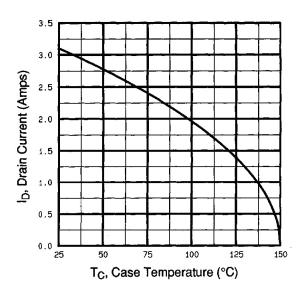


Fig. 9 - Maximum Drain Current vs. Case Temperature

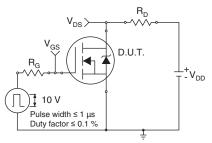


Fig. 10a - Switching Time Test Circuit

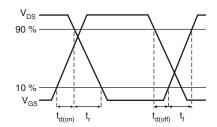


Fig. 10b - Switching Time Waveforms

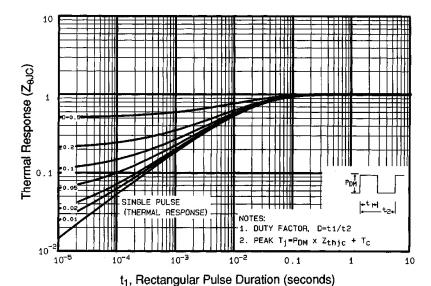


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

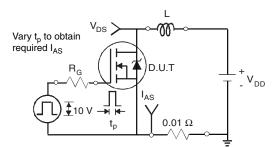


Fig. 12a - Unclamped Inductive Test Circuit

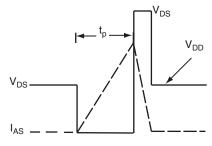


Fig. 12b - Unclamped Inductive Waveforms

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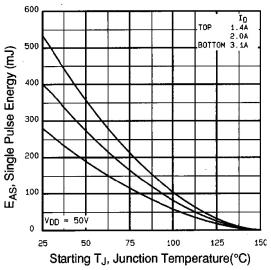


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

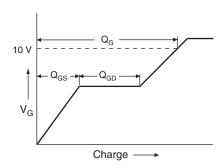


Fig. 13a - Basic Gate Charge Waveform

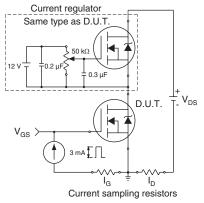
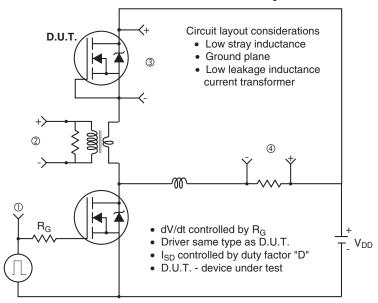
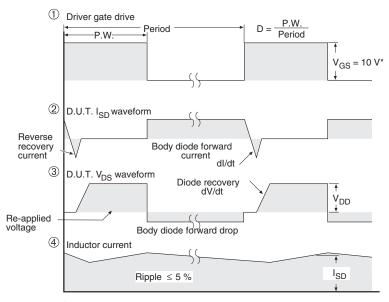


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com